WHAT IS CLAIMED IS:

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1.	A method	for	manufacturing	a semiconductor	device.	comprising
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forming semiconductor film on an insulating surface;

adding a metal element for promoting crystallization to the amorphous semiconductor film;

heating the amorphous semiconductor film to form a crystallized semiconductor film;

irradiating a continuous wave laser beam to the crystallized semiconductor film; and

removing an upper portion of the crystallized semiconductor film to which the continuous wave laser beam is irradiated.

- 2. A method according to claim 1, wherein the upper portion is a region including the metal element.
  - 3. A method for manufacturing a semiconductor device, comprising:

    forming semiconductor film on an insulating surface;

    adding a metal element for promoting crystallization to the amorphous semiconductor film;

heating the amorphous semiconductor film to form a crystallized semiconductor film;

irradiating a continuous wave laser beam to the crystallized semiconductor film; and

- removing an upper portion of the crystallized semiconductor film to reduce a concentration of the metal element in the crystallized semiconductor film to a lower detection limit of SIMS (secondary ion mass spectroscopy).
- 4. A method according to claim 3, wherein the upper portion is a region 30 including the metal element.

- 5. A method according to claim 3, wherein the <u>lower detection limit</u> of SIMS (secondary ion mass spectroscopy) is  $1 \times 10^{17} / \text{cm}^3$ .
- 5 6. A method according to claim 1, wherein the upper portion is removed by one of wet etching, dry etching, and CMP (Chemical Mechanical Polishing).
  - 7. A method according to claim 4, wherein the upper portion is removed by one of wet etching, dry etching, and CMP (Chemical Mechanical Polishing).

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- 8. A method according to claim 1, wherein the continuous wave laser beam is emitted from one of continuous wave Nd:YAG laser, continuous wave Nd:YVO₄ laser, continuous wave Nd:YAIO₃ laser, continuous wave glass laser, continuous wave ruby laser, continuous wave alexandrite laser, and continuous wave Ti:sapphire laser.
- 9. A method according to claim 4, wherein the continuous wave laser beam is emitted from one of continuous wave Nd:YAG laser, continuous wave Nd:YVO₄ laser, continuous wave Nd:YLF laser, continuous wave Nd:YAlO₃ laser, continuous wave glass laser, continuous wave ruby laser, continuous wave alexandrite laser, and continuous wave Ti:sapphire laser.
- 10. A method according to claim 8, wherein the continuous wave laser beam is second harmonic or third harmonic.

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- 11. A method according to claim 9, wherein the continuous wave laser beam is second harmonic or third harmonic.
- 12. A method according to claim 1, wherein the continuous wave laser beam30 is emitted form one of continuous wave Ar laser and continuous wave Kr laser.

- 13. A method according to claim 4, wherein the continuous wave laser beam is emitted form one of continuous wave Ar laser and continuous wave Kr laser.
- 5 14. A method for manufacturing a semiconductor device, comprising:

forming semiconductor film on an insulating surface;  $\sim$ 

adding a metal element for promoting crystallization to the amorphous semiconductor film;

heating the amorphous semiconductor film to form a crystallized semiconductor film;

irradiating a continuous wave laser beam to the crystallized semiconductor film; and

using CMP to remove an upper portion of the crystallized semiconductor film to which the continuous wave laser beam is irradiated.

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- 15. A method according to claim 14, wherein the upper portion is a region including the metal element.
- 16. A method according to claim 14, wherein the continuous wave laser beam is emitted from one of continuous wave Nd:YAG laser, continuous wave Nd:YVO₄ laser, continuous wave Nd:YLF laser, continuous wave Nd:YAlO₃ laser, continuous wave glass laser, continuous wave ruby laser, continuous wave alexandrite laser, and continuous wave Ti:sapphire laser.
- 25 17. A method according to claim 16, wherein the continuous wave laser beam is second harmonic or third harmonic.
  - 18. A method according to claim 14, wherein the continuous wave laser beam is emitted form one of continuous wave excimer laser, continuous wave Ar laser, and continuous wave Kr laser.